

# INTERNATIONAL STANDARD

**IEC**  
**60770-2**

Second edition  
2003-01

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## **Transmitters for use in industrial-process control systems –**

### **Part 2: Methods for inspection and routine testing**

*Transmetteurs utilisés dans les systèmes de conduite  
des processus industriels –*

*Partie 2:  
Méthodes pour l'inspection et les essais individuels de série*



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International Electrotechnical Commission, 3, rue de Varembé, PO Box 131, CH-1211 Geneva 20, Switzerland  
Telephone: +41 22 919 02 11 Telefax: +41 22 919 03 00 E-mail: [inmail@iec.ch](mailto:inmail@iec.ch) Web: [www.iec.ch](http://www.iec.ch)



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## CONTENTS

FOREWORD .....	3
INTRODUCTION .....	4
1 Scope and object .....	5
2 Normative references .....	5
3 Terms and definitions .....	6
4 Sampling for test .....	7
5 Performance tests .....	7
5.1 Test conditions .....	7
5.2 Preconditioning .....	8
5.3 Adjustments .....	8
5.4 Tests under reference conditions .....	8
5.5 Effects of influence quantities .....	10
6 Test report and documentation .....	12
Figure 1 – Typical measured error plot .....	9
Figure 2 – Two examples of responses to a step input .....	10

## INTERNATIONAL ELECTROTECHNICAL COMMISSION

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**TRANSMITTERS FOR USE IN INDUSTRIAL-PROCESS  
CONTROL SYSTEMS –**
**Part 2: Methods for inspection and routine testing**

## FOREWORD

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International Standard IEC 60770-2 has been prepared by subcommittee 65B: Devices, of IEC technical committee 65: Industrial-process measurement and control.

This second edition cancels and replaces the first edition published in 1989 and constitutes a technical revision.

The text of this standard is based on the following documents:

FDIS	Report on voting
65B/468/FDIS	65B/477/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A bilingual edition may be issued at a later date.

The committee has decided that the contents of this publication will remain unchanged until 2008. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.